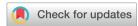
# Materials Advances



## PAPER

View Article Online
View Journal | View Issue



Cite this: *Mater. Adv.*, 2025, **6**, 1822

Received 29th October 2024, Accepted 7th February 2025

DOI: 10.1039/d4ma01087f

rsc.li/materials-advances

# Gigantic enhancement of optoelectrical properties in polythiophene thin films *via* MoS<sub>2</sub> nanosheet-induced aggregation and ordering

Mitu Chauhan, Da Anand Kumar Singh, Db Vivek Chaudhary, Dc Rajiv Kumar Pandey Dd and Arun Kumar Singh xa

Conducting polymers (CPs), such as poly(3,3-dialkylquarterthiophene) (PQT-12), are attractive candidates for flexible thin-film electronics due to their cost-effectiveness and mechanical flexibility. However, the industrial application of CPs is limited by poor crystallinity and disordered polymer chain orientation. Herein, we report the enhancement in optical, structural, and electronic properties of PQT-12 by incorporating  $MoS_2$  nanosheets in the polymer matrix. The PQT-12/ $MoS_2$  nanocomposite exhibits improved crystallinity, molecular ordering, and charge transport properties, as evidenced by enhanced UV-visible absorption, quenched photoluminescence, and increased coherence length in X-ray diffraction. The floating-film transfer method (FTM), a scalable technique for large-area film fabrication has been used for thin film deposition. The nanocomposite film reveals a more ordered nano-fibrillar network in atomic force microscopy images, which is crucial for efficient charge transport. The charge transport has been studied by fabricating organic field-effect transistors (OFETs) and Schottky diodes. The nanocomposite based OFETs have shown mobility up to  $3.6 \times 10^{-3}$  cm  $V^{-1}$  s<sup>-1</sup> with an on/off ratio of  $10^4$ , while Schottky diodes exhibit enhanced ideality factor, rectification ratio, and barrier height. These improvements are attributed to charge transfer interactions and enhanced polymer chain alignment induced by  $MoS_2$  nanosheets, demonstrating their potential for high-performance flexible electronics.

#### 1. Introduction

Solution-processable conducting polymers (CPs) are increasingly being considered for the cost-effective production of flexible thin-film electronic devices used in many technological applications due to their ease of use and inherent flexibility. The solution processability, cost-effectiveness, and flexibility of CPs make them exceptionally better than other semiconductors (e.g., conventional semiconductors, oxide semiconductors, perovskites, and low-dimensional semiconductors), which can enable the fabrication of more complex devices. Many organic electronic devices, including organic Schottky diodes (OSDs), organic light emitting diodes, organic field effect transistors (OFETs), and organic solar cells, flexible information displays, electronic skin, digital healthcare monitoring, brain signal

Among CPs, polythiophenes have become the benchmark polymer semiconductor materials for electronic devices. The solution-processable derivative of polythiophene, poly(3,3'''-dialkylquarterthiophene) (PQT-12), has attracted wide scientific interest due to its ability to self-assemble, better air stability, and superior charge transport characteristics than other polymers of the thiophene family. The interchain stacking and intermolecular interdigitation through alkyl side chains can tune the charge transport properties of PQT-12. The alkyl side chains of PQT-12 not only provide additional ordering but also improve their solubility in common organic solvents. The effect of chain orientation,  $\pi$ - $\pi$  stacking, alkyl side-chain interactions, and molecular weight-dependent chain ordering on overall

recording,<sup>10</sup> and supercapacitors<sup>11</sup> have been demonstrated. The development of organic thin-film electronic devices is currently underway; however, the poor crystallinity and random orientations of the polymer chains limit their performance. The performance of these electronic devices very strongly depends on intermolecular and intramolecular interactions, molecular alignment, crystallinity, and the interface properties of CPs.<sup>5,12,13</sup> Therefore, it is necessary to control the inter/intramolecular interactions, surface morphology, and orientation of the polymer chains for enhancing the performance of electronic devices.

<sup>&</sup>lt;sup>a</sup> Department of Pure and Applied Physics, Guru Ghasidas Vishwavidyalaya, Bilaspur (C.G.)-495009, India. E-mail: arunsingh.itbhu@gmail.com

b School of Engineering and Technology, Vivekananda Institute of Professional Studies-Technical Campus (VIPS-TC), Pitampura, New Delhi-110034, India

<sup>&</sup>lt;sup>c</sup> School of Applied and Engineering Physics, Mohammed VI Polytechnic University, Ben Guerir, 43150, Morocco

<sup>&</sup>lt;sup>d</sup> SKKU Advanced Institute of Nanotechnology, Sungkyunkwan University, Suwon 16419, South Korea

Paper

device performance has been explained well and presented in several existing studies. 18 Solvent-evaporation dependent crystallization kinetics and aggregated structures in films of PQT-12 have

also been demonstrated previously. 19 Thus, there is a need for a cautious optimization of the film fabrication. Thin-film fabrication via solution-state self-assembly is a vital approach for future organic-semiconductor based electronic devices because the performance of these devices mainly depends on the aggregation and alignment of the polymer chains in the thin film.

In recent years, two-dimensional (2D) nanomaterials have attracted enormous attention because they provide remarkable tuning of structural, optical and optoelectronic properties. Molybdenum disulfide (MoS<sub>2</sub>) is one of the most explored transition metal dichalcogenides (TMDCs) and is well-known for exhibiting layer dependent electronic and optical properties; making it potentially useful in next-generation nanoelectronics.<sup>20</sup> MoS<sub>2</sub>-based FETs have recently attracted a lot of interest for several applications, including photoelectrical detectors, gas sensors, and ultra-thin integrated circuits. 21,22 The MoS nanosheets in CPs/MoS2 nanohybrids provide interconnected pathways that result in highly efficient long-range charge transport and improved carrier hopping along the  $\pi$ - $\pi$  stacking direction in organic electronic devices, which is highly necessary for planar devices. But the exact nature of charge-transfer interactions between the conducting polymer and MoS2 still needs to be understood.<sup>23–25</sup> To the best of our knowledge the structural, optical and electrical properties along with the nature and mechanism of interaction involved between the POT-12 polymer and MoS<sub>2</sub> have not yet been reported.

In this study, we have investigated the self-assembly and ordering of PQT-12 chains in thin films mediated by MoS2 nanosheets. The floating film transfer (FTM) method is used to deposit homogeneous, large-area, and high-quality films. The PQT-12/MoS<sub>2</sub> nanocomposite films exhibit significantly enhanced photophysical and charge transport properties compared to pristine PQT-12. The absorption and emission spectra, along with the atomic force microscopy (AFM) images, indicate improvements in optical and morphological properties. Incorporating MoS2 flakes into the polymer matrix introduces novel electronic interactions, enhancing crystallinity, polymer chain length, and network connectivity, resulting in more efficient charge carrier transport pathways. We also report a significant improvement in charge carrier mobility and on/off ratio for the nanocomposite films, along with a reduction in charge trap density. Additionally, we fabricated organic Schottky diodes using the configuration Al/PQT-12/MoS<sub>2</sub>/ ITO and analyzed their current density-voltage characteristics, comparing them with pristine PQT-12 diodes to understand the conduction mechanism at the metal-semiconductor interface.

## 2. Experimental details

#### 2.1. Synthesis of the nanocomposites and film formation

PQT-12 is purchased from the American Dye Source, Inc., USA, and used in our study without any additional refining. MoS<sub>2</sub> crystals were purchased from SPI supplies, USA, and other

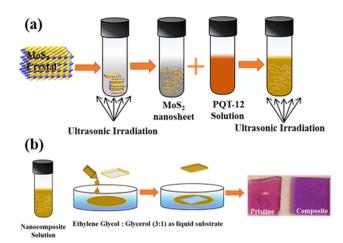


Fig. 1 (a) Synthesis mechanism of PQT-12/MoS<sub>2</sub> nanocomposite. (b) Schematic diagram of thin film formation by floating film transfer method and optical image of prepared films over glass substrate.

chemicals were purchased from Sigma-Aldrich. Before preparing the PQT-12/MoS<sub>2</sub> nanocomposite, 1 mg of MoS<sub>2</sub> flakes were exfoliated in anhydrous chloroform via sonication for 5 h at 30 kHz similar to as discussed in our previous reports.<sup>23</sup> 30 μL of exfoliated MoS2 nanosheet solution was added dropwise to 3 mg PQT-12 in 970 µL anhydrous chloroform in glass vials to prepare the concentration 1 wt% MoS<sub>2</sub> in PQT-12. This 1 wt% concentration of MoS2 was chosen according to our previous work.<sup>23</sup> During dropwise addition of MoS<sub>2</sub> nanosheets in PQT-12, 15 min of sonication was performed in each step. The prepared solution was finally sonicated for 3 h approximately at 5-10 °C before the use of the solutions for the formation of thin films. The preparation of the PQT-12/MoS<sub>2</sub> nanocomposite is schematically shown in Fig. 1(a).

For the formation of oriented and smooth thin films over the substrates (glass and SiO2/Si), we used 1:3 mixtures of glycerol and ethylene glycol as the liquid substrate. 10 µL of PQT-12/MoS<sub>2</sub> solution was dropped onto the liquid substrate for the formation of a thin film of PQT-12/MoS<sub>2</sub> nanocomposite at the air-liquid interface. The detailed mechanism of the formation of the thin film over the liquid substrate is discussed elsewhere. 23,26-28 The compact thin films were transferred over the glass, ITO coated glass and SiO2/Si substrates via horizontal stamping, as depicted in Fig. 1(b). For comparison purpose, we also prepared a thin film of pristine PQT-12 the same as the formation of thin films of the nanocomposite.

#### Characterizations and device fabrication

The UV-Vis absorption spectra of PQT-12 and PQT-12/MoS<sub>2</sub> solutions and thin films on a glass substrate were recorded in the range from 300 nm to 800 nm using a dual-beam spectrophotometer (PerkinElmer Lambda 25, Germany) to determine the effect of MoS<sub>2</sub> nanosheets on aggregation and ordering. The photoluminescence emission spectrum of the sample was recorded using a Cary Eclipse Spectrophotometer. The structural characterization of the PQT-12 and PQT-12/MoS2 films was carried out by using the grazing incidence X-ray diffraction

(GIXD) measurement (Rigaku smart lab system, thin film XRD) equipped with an in-plane diffractometer at a 0.2° grazing angle. The surface morphology and thickness of the pristine PQT-12 and PQT-12/MoS<sub>2</sub> films coated on the SiO<sub>2</sub>/Si substrate were measured by using an AFM (NT-MDT, Russia, model PRO 47) operating in tapping mode. The thickness of the film was found to be 20  $\pm$  2 nm in all cases. To examine the MoS<sub>2</sub> nanosheets and distribution of MoS<sub>2</sub> in the polymer matrix. transmission electron microscopy (TEM) (FEI, Tech G2 New Zealand) was employed. To measure the charge transport properties of PQT-12 and PQT-12/MoS<sub>2</sub> films, we fabricated both diodes and transistors. For diode fabrication, first we transferred POT-12 and POT-12/MoS2 thin films over a prepatterned ITO substrate, the same as discussed above. The 90 nm aluminum (Al) top electrodes were deposited *via* thermal vacuum evaporation (HIND HIVAC model 12A4D) on PQT-12 and POT-12/MoS<sub>2</sub> thin film coated ITO substrates through a shadow mask keeping the active area for the devices at  $1 \times 1 \text{ mm}^2$ . All the ITO and SiO<sub>2</sub>/Si (heavily p-doped Si) substrates were cleaned using the standard method before device fabrication. The SiO<sub>2</sub> (300 nm)/Si substrate treated with octyltrichlorosilane (OTS) in toluene is used as a gate dielectric and has a capacitance equal to 10 nF cm<sup>-2</sup>.<sup>29</sup> The gold (Au) source-drain electrodes of thickness 30 nm were deposited by a thermal evaporating system (HIND HIVAC model 12A4D) with a nickel mask that has 50 µm channel length and 2 mm channel width. Finally, the electrical transport properties of all samples

are investigated using the Keysight parameter analyzer (B1500A) in ambient conditions.

#### 3. Results and discussion

Fig. 2(a) and (b) display the UV-Vis absorption spectra of pristine POT-12 and the POT-12/MoS<sub>2</sub> nanocomposite respectively in solution and the thin-film state. In solution form, the strong absorption peak at 450 nm corresponds to  $\pi$ - $\pi$ \* transition that stems from strong conjugation in the PQT-12 backbone. A notable bathochromic shift is observed in the absorption peaks of the POT-12 and POT-12/MoS<sub>2</sub> nanocomposite thin films. This shift is attributed to increased interchain interactions and changes in molecular polarity caused by evaporation of the polar solvent environment. Additionally, the formation of the film on a liquid substrate introduces a directional alignment and extended crystalline domains, which further contributes to the red shift.<sup>30</sup> In thin films, the UV-vis spectra of both pristine PQT-12 and PQT-12/MoS<sub>2</sub> reveal three distinct absorption peaks at 502, 541, and 579 nm, which correspond to  $A_{0-2}$ ,  $A_{0-1}$ , and  $A_{0-0}$  transitions, respectively. The peaks at 541 and 579 nm are more pronounced in the PQT-12/MoS<sub>2</sub> films compared to the pristine PQT-12 films. These peaks are associated with the ordered coplanar orientation of the conjugated chain and alignment of the side chains due to incorporation of MoS<sub>2</sub> bridging among the polymer chains enhancing  $\pi$ – $\pi$  stacking.<sup>14,31,32</sup>

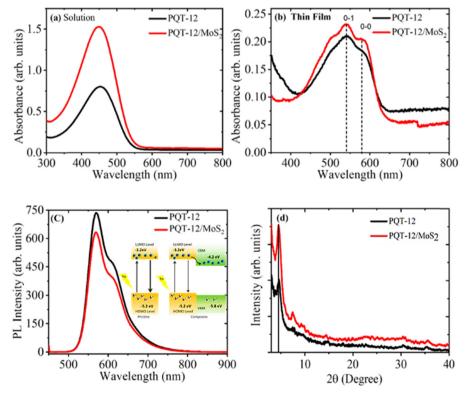


Fig. 2 UV-vis absorption spectra of pristine PQT-12 and PQT-12/MoS $_2$  (a) solution and (b) thin films. (c) Photoluminescence spectra of the pristine PQT-12 and PQT-12/MoS $_2$  nanocomposite solution. The figure inset shows the schematic band diagram. (d) XRD profiles of pristine PQT-12 and PQT-12/MoS $_2$  films.

Paper Materials Advances

Fig. 2(c) compares the photoluminescence (PL) emission spectra of PQT-12 and PQT-12/MoS2 nanocomposite solutions with an excitation wavelength of 500 nm. Both solutions show a strong PL band peaking at 570 nm with a small side hump at 611 nm arising from excitonic transitions of the conjugated core of PQT-12. The incorporation of MoS<sub>2</sub> in PQT-12 shows a reduction in the PL intensity, which indicates the existence of non-radiative transitions in the nanocomposite system, which may arise from overlapping of the absorption band of MoS<sub>2</sub> with the emission band of the polymer indicating the existence of a long rang electronic energy transfer process. 33,34 Since the absorption spectra of MoS2 extend up to the near-infrared region with two direct excitonic bands, this opens up the possibility of electronic interaction between PQT-12 and MoS<sub>2</sub>. <sup>35</sup> Hence, quenching of PL of the nanocomposite can be understood by the schematic representation of the band diagram in the inset of Fig. 2(c). The movement of excited electrons from the LUMO level of POT-12 towards the conduction band of MoS<sub>2</sub> due to favorable band alignment causes quenching in the PL spectra and reduces recombination of excitons in the HOMO level, which results in better electronic performance of the composite.

XRD of pristine PQT-12 and PQT-12/MoS2 thin films has been performed to examine the orientation, coherence length, and interplanar spacing. Pristine PQT-12 and PQT-12/MoS2 composite films have (100) diffraction peaks that appeared at  $2\theta$  angles of 4.648° and 4.560°, respectively, as shown in Fig. 2(d). The corresponding interlayer d-spacing  $(d_{h00})$  for the PQT-12 and PQT-12/MoS $_2$  thin films is found to be 16.65 Å and 16.49 Å, respectively. The shrinkage of the interlayer distance in the PQT-12/MoS<sub>2</sub> thin film indicates denser packing of atoms/ molecules within the composite. This compactness causes more overlapping of the  $\pi$  electron wavefunction, which in turn enhances the delocalization of holes along the  $\pi$ - $\pi$  stacking direction.<sup>23</sup> It is due to the involvement of stronger binding forces in-between the molecules, which are discussed in detail in the later section. The thin films exhibit (h00) molecular stacking along the alkyl chain direction and normal to the substrate, which is suitable for in-plane electronic devices. However, a decrease in FWHM for the (100) reflection peak reflects an increase of coherence length from 10.7 nm in the pristine PQT-12 film to 12.8 nm in the nanocomposite film. Coherence length for the films is calculated by the Debye-Scherer relation:36

$$L_{\rm c} = \frac{0.9\lambda}{\beta\cos\theta} \tag{1}$$

where  $L_{\rm c}$  is the coherence length,  $\lambda$  is the wavelength of incoming X-rays,  $\beta$  is the FWHM of the diffraction peak and  $\theta$  is the scattering angle. The increase in coherence length may indicate an increase in chain length of the polymer in the composite.

The morphology of the polymer films is a critical factor in determining the device performance, as the degree of order and connectivity in the film surface can significantly enhance charge carrier transport. In the provided analysis, AFM was

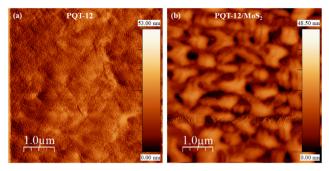


Fig. 3 AFM phase images of (a) pristine PQT-12 and (b) PQT-12/MoS $_2$  films.

used to compare the surface topography of pure PQT-12 films and PQT-12/MoS<sub>2</sub> nanocomposite films (Fig. 3(a) and (b)). The AFM topography of pure PQT-12 films reveals a very smooth and featureless surface. This indicates a lack of significant surface texture or microstructure, which may correlate with lower charge transport efficiency due to the absence of well-defined pathways. In contrast, the nanocomposite films (PQT-12 with MoS<sub>2</sub>) exhibit a globular surface structure. This distinct morphology is characterized by interconnected nanofibrillar networks, which suggest a more ordered packing of the polymer chains. The presence of MoS2 nanosheets is crucial here, as they serve as nucleation sites that promote the selfassembly of PQT-12 chains into nanofibers, likely through  $\pi$ - $\pi$ stacking with a preferential edge-on orientation. Ahmad et al. reported similar morphological changes in a different polymer system (P3HT/MoS<sub>2</sub>), where the incorporation of MoS<sub>2</sub> led to the formation of longer, more ordered polymeric fibers.<sup>31</sup> These globular structures are interconnected nano-fibrillar networks, which are characteristics of ordered packaging.<sup>37,38</sup> The phase imaging in their study also revealed a reduction in height and the emergence of a globular structure in tapping mode, akin to the findings for the PQT-12/MoS<sub>2</sub> films. The change in morphology upon the addition of MoS2 is attributed to the large surface area of the MoS2 nanosheets, which act as nucleation centers for long range aggregation. The strong dipole-dipole interactions between the conjugated core of the polymer and the localized electron clouds of sulfur in MoS<sub>2</sub> facilitate the aggregation process around the nanosheets. This leads to the formation of long polymer nanofibers and interconnected nanofibrillar networks. These networks not only enhance the order of the polymer chains, but also act as physical bridges between neighboring fibers, potentially improving intrinsic charge carrier transport and thus device performance.

The 2D MoS<sub>2</sub> nanosheets are successfully obtained by the liquid-phase exfoliation method. The TEM image of 2D MoS<sub>2</sub> nanosheets is shown in Fig. 4(a), which shows ultrathin layers with lateral dimensions across hundreds of nanometers. Fig. 4(b) depicts high-resolution TEM images of the obtained nano-sheets with crystal lattice fringes of 0.28 nm assigned mainly to the (001) planes of MoS<sub>2</sub>, which revealed the mono- or few-layer of MoS<sub>2</sub>. The inset of Fig. 4(b) shows the selected area electron diffraction (SAED) pattern of the MoS<sub>2</sub> nanosheets;

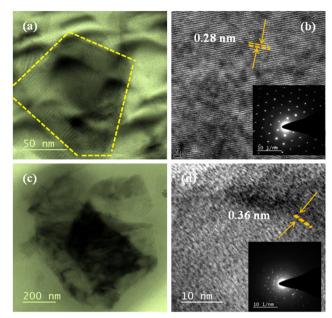


Fig. 4 (a) TEM image of MoS<sub>2</sub> nanosheets represented by the yellow dotted line. (b) HR-TEM of 2D MoS<sub>2</sub> nanosheets showing the lattice fringes and inset displaying the SAED pattern of the MoS<sub>2</sub> nanosheets. (c) TEM image of MoS<sub>2</sub> nanosheets in the PQT-12 matrix. (d) HRTEM images of PQT-12/MoS<sub>2</sub> and inset showing the SAED pattern of the PQT-12/MoS<sub>2</sub>.

it attributes the hexagonal diffraction pattern of the spots and highly crystalline nature. Fig. 4(c) shows the TEM image of the PQT-12/MoS $_2$  nanocomposite, which clearly revealed that MoS $_2$  nanosheets are covered by PQT-12 polymer chains as well as uniformly distributed in the polymer matrix. HRTEM images of the PQT-12/MoS $_2$  nanocomposite demonstrate the fringe spacing of 0.36 nm corresponding to the (0k0) plane, revealing the edge-on orientation of the film, as shown in Fig. 4(d). The SAED pattern of the PQT-12/MoS $_2$  nanocomposite shows several rings with different intensities that reveal the different periodicities of the structures and high crystallinity.

The interaction between the 2D layered material  $MoS_2$  and the organic polymer can be further elucidated by the schematic diagram in Fig. 5. In this diagram, the layered crystal structure of  $MoS_2$  is depicted, where molybdenum atoms are sandwiched between two sulfur atoms within each  $MoS_2$  layer. The layered

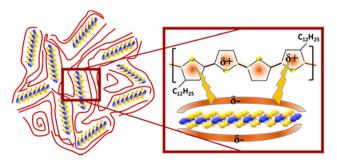


Fig. 5 Schematic representation of intermolecular interaction between PQT-12 and  $MoS_2$  nanosheets.

structure allows sulfur atoms, which possess lone electron pairs, to generate an electron cloud on the outer surface of the layers. This electron cloud interacts with the conjugated backbone of the polymer via electrostatic interactions, significantly influencing the morphological, electrical, and optical properties of the conjugated polymer. The interaction between the outer electron cloud of the MoS2 layer and the aromatic ring of the polymer leads to the formation of a globular structure, as observed in the AFM image of the nanocomposite. This interaction creates a stronger attractive force compared to the typical dipole-dipole interactions or van der Waals forces. Consequently, more polymer chains are drawn towards the MoS<sub>2</sub> nanosheets, resulting in the emergence of globular patch-like structures. These patches are indicative of longer and more aligned polymer chains in the nanocomposite, as supported by previous studies.37 The increased coherence length in the nanocomposite, evidenced by XRD analysis, further supports the notion of enhanced alignment and order within the polymer chains. Additionally, XRD and UV-visible absorption spectra confirm the enhanced crystallinity, denser packing, and more aligned orientation of the polymer chains, all of which are attributed to the interaction between the MoS2 and polymer chains. These morphological changes are crucial as they suggest the creation of more efficient pathways for charge transport, reduced resistance, and an overall increase in mobility.<sup>39</sup> According to Mott's variable-range hopping conduction mechanism and percolation theory, efficient charge transport in materials is governed by the availability of multiple conducting channels. In hybrid materials like the polymer/MoS<sub>2</sub> nanocomposite, the existence of multiple pathways for charge carrier transport is crucial. The crystalline and self-assembled polymer chains, which are interconnected via MoS2 nanosheets, acting as the most efficient channels for charge transport. This interconnection not only facilitates better charge mobility, but also enhances the overall performance of the material in electronic devices.

The enhanced crystallinity and improved morphology of the PQT-12/MoS<sub>2</sub> nanocomposite film motivated an in-depth investigation of its electrical and charge transport properties, both along the film plane (in-plane) and across the film (outof-plane), using organic field-effect transistors (OFETs) and Schottky diode configurations. To study these properties, OFETs were fabricated using PQT-12 and PQT-12/MoS<sub>2</sub> films, with a channel length of 50 μm and a width of 2 mm, employing a bottom-gate, top-contact configuration. Fig. 6(a) presents the schematic diagram of the fabricated transistors. The PQT-12/MoS<sub>2</sub> nanocomposite demonstrated p-type charge transport, as evidenced by the  $I_D$  versus  $V_{GS}$  characteristics of the transistors. Consistent results were obtained across multiple batches of devices, confirming the reproducibility of the fabrication process. Fig. 6(b) also shows significant enhancement of the drain current in the PQT-12/MoS2 film as compared to the pristine PQT-12 film due to enhanced charge transportation in the PQT-12/MoS<sub>2</sub> film. This enhanced charge transportation is estimated by enhancement of mobility  $(\mu)$  by a factor of 10 for nanocomposite films, i.e,  $0.4 \times 10^{-3}$  and  $3.6 \times 10^{-3}$  cm<sup>2</sup> V<sup>-1</sup> s<sup>-1</sup>

**Materials Advances** Paper

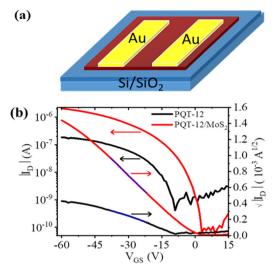


Fig. 6 (a) Schematic representation of the fabricated OFET devices. (b) Transfer characteristics of pristine PQT-12 and PQT-12/MoS<sub>2</sub> filmbased OFETs.

for the PQT-12 and PQT-12/MoS2 nanocomposite, respectively. The band mobility and threshold voltage are calculated in the saturation regime using the equations:<sup>38</sup>

$$I_{\rm ds} = \mu C_{\rm o} \frac{W}{2L} (V_{\rm G} - V_{\rm Th})^2 \tag{2}$$

where  $\mu$  is band mobility, L is the channel length, W is the channel width,  $C_0$  is the capacitance per unit area of gate oxide,  $V_G$  is the applied gate voltage, and  $V_{\rm Th}$  is threshold voltage. The subthreshold swing (SS) as another important parameter, was obtained by linear fitting of the slope in the semi-logarithmic plot of  $I_{\rm DS}$  versus  $V_{\rm GS}$  and it is defined as  $^{27,40}$ 

$$SS = \left[ \frac{d(\log I_{DS})}{dV_{GS}} \right]^{-1} \tag{3}$$

The subthreshold swing can also be related to the density of interfacial traps (Ninterface) and density of deep/shallow bulk traps  $(N_{\text{bulk}})$  by the equation<sup>40,41</sup>

$$SS = \frac{K_{\rm B}T \ln 10}{q} \left[ 1 + \frac{q \left[ q N_{\rm interface} + \sqrt{\varepsilon N_{\rm bulk}} \right]}{C_{\rm o}} \right]$$
 (4)

This may be simplified as follows

$$N_{\text{interface}} = \frac{C_{\text{o}}}{q^2} \left| \frac{\text{SS}}{\ln 10 \frac{K_{\text{B}} T}{q}} - 1 \right|$$
 (5)

where  $\frac{K_{\rm B}T}{q}$  is the thermal voltage and q is the unit charge. From eqn (3) the subthreshold swing is extracted as 5.93 V dec<sup>-1</sup> for pristine and 3.21 V  $\mathrm{dec^{-1}}$  for composite devices. The deep interfacial trap density was calculated to be  $6.17 \times 10^{12} \; eV^{-1} \; cm^{-2}$ and  $3.31 \times 10^{12} \text{ eV}^{-1} \text{ cm}^{-2}$  for the PQT-12 and PQT-12/MoS<sub>2</sub> nanocomposite, respectively. The decrease in trap density

Table 1 Electronic parameters of the fabricated transistors

Device (transistors)	Mobility $\mu$ (cm <sup>2</sup> V <sup>-1</sup> s <sup>-1</sup> )	On/off ratio	Threshold voltage $V_{\rm Th}$ (V)	Interfacial trap density (eV <sup>-1</sup> cm <sup>-2</sup> )
PQT-12 PQT-12/MoS <sub>2</sub>	$0.4 \times 10^{-3}$ $3.6 \times 10^{-3}$	$10^2 \\ 10^4$	-9 3	$6.17 \times 10^{12} \\ 3.31 \times 10^{12}$

explains the enhancement of charge transport in the nanocomposite. Also, a positive shift in the  $V_{\rm Th}$  from -9 V for pristine PQT-12 to 3 V for the PQT-12/MoS<sub>2</sub> nanocomposite is observed. This might be associated with enhancement of molecular ordering in the polymeric chains after incorporation of MoS<sub>2</sub> in PQT as evident by UV-vis spectroscopy.<sup>39</sup> The on/off ratio for the POT-12/MoS<sub>2</sub> transistor is found to be 10<sup>4</sup>, which is two orders of magnitude higher than that of the PQT-12 transistors (on/off ratio  $\sim 10^2$ ). Table 1 summarizes the performance of our fabricated OFETs.

Furthermore, the charge transport properties were investigated, particularly perpendicular to the film surface by sandwiched configuration Al/PQT-12/ITO and Al/PQT-12/MoS<sub>2</sub>/ITO. The unipolar conduction mechanism applies to Schottky diodebased structures as the current is controlled by majority charge carriers (in our case hole only). We chose ITO as the anode to create Ohmic contact with the HOMO level of active material and aluminum as the cathode to create a Schottky junction. The schematic representation of Schottky contact is shown in Fig. 7(a). After junction formation, the Gaussian-like distribution of the hole wavefunction at the HOMO level generally has a tail on the higher energy side which facilitates the thermionic emission of holes from the semiconductor to metal side to equilibrate the Fermi level. Non-linear behavior in the current density-voltage (I-V) characteristics reveals the formation of a Schottky barrier at the interface of the metal and semiconductor. Thus, the current density versus voltage plot can be elucidated by thermionic emission theory and Mott-Gurney law related to space charge limited current (SCLC). The J-V characteristics of the Al/PQT-12/ITO and Al/PQT-12/MoS2/ITO devices are shown in Fig. 7(b). The J-V relationship of the Schottky diode obeying the thermionic emission model is given by13,42

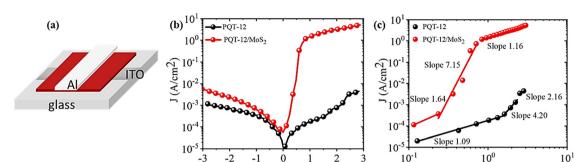
$$J = J_0 \left[ \exp\left(\frac{qV_{\rm D}}{\eta kT}\right) - 1 \right] \tag{6}$$

where q,  $V_D$ ,  $\eta$ , k, and T are electronic charge, bias voltage, ideality factor, Boltzmann constant and absolute temperature, respectively. The reverse saturation current density  $J_0$  and barrier height are related as:

$$J_0 = A_{\text{eff}} A^* T^2 \exp\left(\frac{-q\phi_{\text{B}}}{kT}\right) \tag{7}$$

 $A_{\rm eff}$  is the effective diode area,  $A^*$  is the Richardson constant having value 1.2 A cm<sup>-2</sup> K<sup>-2</sup> and  $\varphi_B$  is the barrier height. In forward bias conditions, i.e.  $qV_D/\eta kT \gg 1$ , eqn (7) modifies as:42

**Materials Advances** 



$$ln J = ln J_0 + \frac{qV_d}{\eta kT}$$
(8)

The ideality factor value for all the devices is measured from the slope of the linear region of the semi logarithmic *J-V* plot according to eqn (8). The ideality factor was obtained as 19 and 5 for devices ITO/PQT-12/Al and ITO/PQT-12-MoS<sub>2</sub>/Al, respectively. The decrease in ideality factor for the nanocomposite-based device is attributed to better formation of the interface, which is related to the enhanced morphology, increase in crystallinity and decrease in trap charge density, which results in better charge transport concluded from the above sections. Furthermore, the reverse saturation current density  $J_0$  was obtained by extrapolating the linear portion of semi-log J-V to the J axis, which is found to be 1.84  $\mu$ A and 22.27 µA for ITO/POT-12/Al and ITO/POT-12-MoS<sub>2</sub>/Al diodes, respectively. The reverse saturation current density is used to calculate interfacial barrier height for the charge carriers  $\varphi_{\rm B}$ by using eqn (7), which is estimated as 0.64 eV and 0.55 eV for ITO/PQT-12/Al and ITO/PQT-12-MoS<sub>2</sub>/Al, respectively. This reduction of barrier height might be due to the formation of a charge transfer complex, which facilitates creation of delocalized states that enhance the charge transport pathway as explained in the above sections. The electronic parameter of our fabricated Schottky diodes is given Table 2.

(c) log J versus log V plot for Au/PQT-12/Al, and Au/PQT-12-MoS<sub>2</sub>/Al.

Non-linear behavior in the J–V characteristics reveals the existence of different conduction mechanisms in the devices. The J–V characteristic follows a universal power law of the form  $J \propto V_m$ . The value of exponent m defines various conduction mechanisms from ohmic to space charge limited conduction (trap free and trap assisted). Therefore, the slope of the double logarithmic J–V plot defines the dominant conduction mechanism. Fig. 7(c) depicts the double logarithmic J–V plot in the forward bias region, which shows three distinct zones namely

Table 2 Electronic parameters of Schottky contact

Device	Ideality factor $(\eta)$	Reverse saturation current density $J_0 \ (\mu \text{A cm}^{-2})$	Barrier height $\varphi_{\rm B}$ (eV)	Rectification ratio
ITO/PQT-12/Al	19	1.84	0.64	10 10 <sup>3</sup>
ITO/PQT-12/ MoS <sub>2</sub> /Al	5	23.27	0.55	10"

A, B and C, each with different slopes for both the devices. The first region, *i.e.*, A shows a linear relation which means Ohmic conduction prevailed in this region. Ohmic conduction is majorly dominated as the applied voltage is low in this region, the barrier at the interface prevents charge carriers from being injected and current mostly comes from intrinsic carriers that are produced thermally. Next, region B shows the exponential relation of current density with voltage and is defined by trap assisted space charge limited conduction (TASCLC). The current density and voltage in this region are related with the following equation:<sup>43</sup>

$$J_{\text{TASCLC}} = K \frac{V^{m+1}}{d^{2m+1}} \tag{9}$$

where K and m are defined as:  $K = N_{\text{HOMO}} \mu q^{1-m} \left(\frac{m\varepsilon_r \varepsilon_0}{N_{\text{t}}(m+1)}\right)^m \left(\frac{2m+1}{m+1}\right)^{m+1}$ , and  $m = \frac{E_{\text{t}}}{kT}$ , the slope of region

B, i.e., m quantifies the exponentially distributed trap states below the quasi Fermi level.  $N_{\text{HOMO}}$  is the density of states in the highest occupied molecular orbital band, q is the electronic charge,  $\mu$  is the intrinsic mobility,  $N_t$  and  $E_t$  are the trap density and the characteristic trap distribution energy, respectively. The trap distribution energy has been evaluated from the slope of region B for both the devices and is found to be 108 meV and 185 meV, respectively for the PQT-12 and PQT-12-MoS<sub>2</sub> devices. In region B, when the applied bias voltage is high enough to inject the carries from the ITO electrodes to the bulk of the semiconductor, the trap states in the semiconducting layer begin to fill and the current increases rapidly due to increased carrier density, resulting in the formation of TASCLC. On the further increase of the applied voltage, the devices enter into the trap free space charge limited conduction (TFSCLC) state where all the charge trapping centers present in the bandgap of the semiconducting layers are filled and the current is only due to space charge limited conduction; therefore this region is termed as trap free space charge limited conduction (TFSCLC). On comparing the plot for both the devices we can see that the transition from region A to region B and then to region C happens at lower bias voltage in the nanocomposite film than the pristine one. This can be explained by the lower barrier height and low trap density of the PQT-12/MoS2 based devices.

#### 4. Conclusions

Paper

In conclusion, the integration of MoS<sub>2</sub> nanosheets into PQT-12 polymer matrices has significantly enhanced the optical, structural, and electronic properties of the resulting nanocomposite thin films. The improved UV-Vis absorption spectra indicate better polymer chain ordering, while the photoluminescence quenching suggests stronger electronic interactions and nonradiative transitions. XRD analysis reveals increased crystallinity, denser molecular packing, and an extended coherence length, which is further supported by atomic force microscopy, showing a globular, interconnected nanofibrillar structure indicative of long polymer chains. These structural improvements contribute to more efficient charge transport pathways, as confirmed by superior electrical performance in organic field-effect transistors and Schottky diodes. The nanocomposite exhibits enhanced charge carrier mobility, reduced trap density, and an improved on/off and rectification ratio, demonstrating its potential for advanced electronic applications. Overall, these findings highlight the advantages of incorporating MoS2 nanosheets into conjugated polymer systems, leading to improved material properties and enhanced device performance.

### Data availability

Data supporting this study is included within the article.

#### Conflicts of interest

There are no conflicts to declare.

## Acknowledgements

Mitu Chauhan and A. K. Singh acknowledge SERB (project SRG/2021/01326), India, for providing financial support during this work. A. K. Singh also acknowledges UGC-DAE-CSR, Indore (project CRS/2021-22/01/359) India, for support. V. C. acknowledges OCP project grant AS70 and 'Chair Multiphysics' led by Mohammed VI Polytechnic University and sponsored by OCP.

#### References

- 1 Y. Lee, B. Kang, S. Jung and J. Kwon, *Npj Flex. Electron.*, 2024, **8**, 41.
- 2 M. Erdoğan, A. R. Deniz and Z. Çaldıran, *J. Photochem. Photobiol. Chem.*, 2023, 443, 114877.
- 3 A. K. Singh and R. Prakash, RSC Adv., 2012, 2, 5277.
- 4 M. Li, J. Zheng, X. Wang, R. Yu, Y. Wang, Y. Qiu, X. Cheng, G. Wang, G. Chen, K. Xie and J. Tang, *Nat. Commun.*, 2022, 13, 4912.
- 5 V. Singh, A. K. Thakur, S. S. Pandey, W. Takashima and K. Kaneto, *Org. Electron.*, 2008, **9**, 790–796.
- 6 B. King and B. H. Lessard, *J. Mater. Chem. C*, 2024, **12**, 5654–5683.

- 7 W. B. Tarique and A. Uddin, *Mater. Sci. Semicond. Process.*, 2023, **163**, 107541.
- 8 T. Lv, W. Zhang, Y. Yang, J. Zhang, M. Yin, Z. Yin, K. Yong and Q. An, *Small*, 2023, **19**, 2301071.
- 9 F. Yin, H. Niu, E. Kim, Y. K. Shin, Y. Li and N. Kim, *InfoMat*, 2023, 5, e12424.
- 10 M. Hjort, A. H. Mousa, D. Bliman, M. A. Shameem, K. Hellman, A. S. Yadav, P. Ekström, F. Ek and R. Olsson, *Nat. Commun.*, 2023, 14, 4453.
- 11 K. Gupta, N. Singh, R. S. Singh, U. P. Azad and A. K. Singh, J. Energy Storage, 2024, 103, 114348.
- 12 V. Chaudhary, R. K. Pandey, R. Prakash, N. Kumar and A. K. Singh, *Synth. Met.*, 2019, **258**, 116221.
- 13 V. Chaudhary, R. K. Pandey, R. Prakash and A. K. Singh, *J. Appl. Phys.*, 2017, **122**, 225501.
- 14 C. Kumar, G. Rawat, H. Kumar, Y. Kumar, R. Prakash and S. Jit, *IEEE Trans. Nanotechnol.*, 2018, 17, 1111–1117.
- 15 A. Kumar, D. K. Jarwal, A. K. Mishra, S. Ratan, C. Kumar, R. K. Upadhyay, B. Mukherjee and S. Jit, *IEEE Photonics Technol. Lett.*, 2020, 32, 677–680.
- 16 C. Kumar, G. Rawat, H. Kumar, Y. Kumar, R. Prakash and S. Jit, *Org. Electron.*, 2017, 48, 53–60.
- 17 R. K. Pandey, A. K. Singh and R. Prakash, J. Phys. Chem. C, 2014, 118, 22943–22951.
- 18 R. K. Pandey, A. K. Singh, N. K. Singh, M. Rabelo, M. Ju, E.-C. Cho, R. Prakash and J. Yi, *Appl. Surf. Sci.*, 2022, 593, 153413.
- 19 M. Pandey, S. S. Pandey, S. Nagamatsu, S. Hayase and W. Takashima, *Thin Solid Films*, 2016, **619**, 125–130.
- 20 B. J. Akeredolu, I. Ahemen, A. N. Amah, A. D. Onojah, J. Shakya, H. N. Gayathri and A. Ghosh, *Heliyon*, 2024, 10, e24964.
- 21 A. H. Abdullah Ripain, N. A. A. Zulkifli, C. L. Tan, W. H. Abd Majid and R. Zakaria, *Appl. Phys. Lett.*, 2023, 123, 061104.
- 22 M. Achqraoui, H. Jebari, N. Bekkioui and H. Ez-Zahraouy, Int. J. Hydrogen Energy, 2024, 51, 623-632.
- 23 V. Chaudhary, R. K. Pandey, P. K. Sahu, R. Prakash, N. Kumar and A. K. Singh, J. Phys. Chem. C, 2020, 124, 8101–8109.
- 24 T. Alamro and M. K. Ram, *Electrochim. Acta*, 2017, 235, 623-631.
- 25 J. Wang, Z. Wu, H. Yin, W. Li and Y. Jiang, *RSC Adv.*, 2014, 4, 56926–56932.
- 26 M. Makrygianni, A. Ainsebaa, M. Nagel, S. Sanaur, Y. S. Raptis, I. Zergioti and D. Tsamakis, *Appl. Surf. Sci.*, 2016, 390, 823–830.
- 27 S. Jana, R. K. Pandey and R. Prakash, ACS Appl. Polym. Mater., 2022, 4, 4818–4828.
- 28 V. Chaudhary, R. K. Pandey, R. Prakash, N. Kumar and A. K. Singh, *Nanotechnology*, 2021, 32, 385201.
- 29 S. P. Tiwari, K. A. Knauer, A. Dindar and B. Kippelen, *Org. Electron. Phys. Mater. Appl.*, 2012, **13**, 18–22.
- 30 S. Hayashi, Mater. Adv., 2020, 1, 632-638.
- 31 R. K. Pandey, W. Takashima, S. Nagamatsu, A. Dauendorffer, K. Kaneto and R. Prakash, *J Appl. Phys*.

32 W.-S. Syu, S.-C. Lin, S.-R. Tseng, C.-Y. Chen, C.-Y. Liu, Y.-C. Chao, H.-F. Meng and S.-F. Horng, *Synth. Met.*, 2010, **160**, 871–875.

**Materials Advances** 

- 33 S. Bhattacharyya and A. Patra, *Bull. Mater. Sci.*, 2012, 35, 719–725.
- 34 G. L. Kabongo, P. S. Mbule, G. H. Mhlongo, B. M. Mothudi, K. T. Hillie and M. S. Dhlamini, *Nanoscale Res. Lett.*, 2016, 11, 418.
- 35 C. Kumar and S. Jit, *IEEE Electron Device Lett.*, 2020, 41, 1556–1559.
- 36 M. Chauhan, R. S. Singh and A. K. Singh, Synth. Met., 2024, 306, 117624.

- 37 R. Ahmad, R. Srivastava, S. Yadav, S. Chand and S. Sapra, ACS Appl. Mater. Interfaces, 2017, 9, 34111–34121.
- 38 N. Nikhil, R. K. Pandey, P. K. Sahu, M. K. Singh and R. Prakash, *J. Mater. Chem. C*, 2018, **6**, 9981–9989.
- 39 R. K. Pandey, A. S. M. Tripathi, S. S. Pandey and R. Prakash, *Carbon*, 2019, **147**, 252–261.
- 40 W. L. Kalb and B. Batlogg, Phys. Rev. B: Condens. Matter Mater. Phys., 2010, 81, 035327.
- 41 Y. Kwon and B. Park, Thin Solid Films, 2016, 599, 145-150.
- 42 A. K. Singh, A. D. D. Dwivedi, P. Chakrabarti and R. Prakash, J. Appl. Phys., 2009, **105**, 114506.
- 43 S. Li, J. Chen and X. Zhou, Jpn. J. Appl. Phys., 2013, 52, 05DB11.